

Search Notes**Application/Control No.**

10/817,454

Examiner

Jezia Riley

Applicant(s)/Patent under Reexamination

CAMPBELL ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
435	6,7,1		
536	23.1,25.3		
530	300,350	2/17/2007	JR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN search enclosed	2/18/2007	JR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner